

**Search Notes**

Application/Control No.

10/816,789

Examiner

Sangwoo Ahn

Applicant(s)/Patent under  
Reexamination

ABANAMI ET AL.

Art Unit

2166

**SEARCHED**

Class	Subclass	Date	Examiner
707	201-204	10/11/2006	SW
709	217,223	10/11/2006	SW
709	230	10/11/2006	SW

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search History Attached (EAST: USPGPUB, USPAT, JPO, EPO, DERWENT, IBM_TDB) text search only	10/11/2006	SW
101 Help Panel	10/11/2006	SW